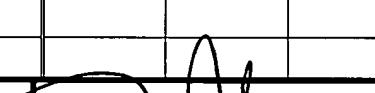
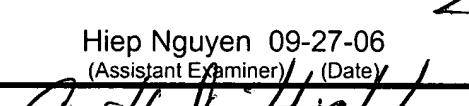


Issue Classification	Application/Control No.	Applicant(s)/Patent under Reexamination
	10/784,302	YAMAMOTO ET AL.
Examiner	Art Unit	
Hiep Nguyen	2816	

ORIGINAL		CROSS REFERENCE(S)					
CLASS	SUBCLASS	CLASS	SUBCLASS (ONE SUBCLASS PER BLOCK)				
327	427	327	434	435	437		
INTERNATIONAL CLASSIFICATION							
H	0	3	K	17/687			
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				/			
							
Hiep Nguyen 09-27-06 (Assistant Examiner) (Date)				Total Claims Allowed: 5			
 10/3/06 (Legal Instruments Examiner) (Date)				TUAN T. LAM PRIMARY EXAMINER 9/28/06 (Primary Examiner) (Date)			
				O.G. Print Claim(s)	O.G. Print Fig.		
				1	7		